

## GDAŃSK UNIVERSITY

## Subject card

Subject name and code	Metrology, PG_00047552							
Field of study	Electronics and Telecommunications							
Date of commencement of studies	October 2023		Academic year of realisation of subject		2023/2024			
Education level	first-cycle studies		Subject group		Obligatory subject group in the field of study Subject group related to scientific research in the field of study			
Mode of study	Full-time studies		Mode of de	Mode of delivery		at the university		
Year of study	1		Language of instruction		Polish			
Semester of study	2		ECTS credits		1.0			
Learning profile	2 general academic profile		Assessment form			assessment		
Conducting unit			Assessment form		onics T	elecom	munications a	and Informatics
Name and surname	Subject supervisor		1	Babicz-Kiewlic				
of lecturer (lecturers)	Teachers		,	Babicz-Kiewlig				
			dr inż. Stanisław Galla					
Lesson types and methods	Lesson type	Lecture	Tutorial	Laboratory	Projec	t	Seminar	SUM
of instruction	Number of study hours	15.0	0.0	0.0	0.0		0.0	15
	E-learning hours inclu	uded: 0.0						_
Learning activity and number of study hours	Learning activity	Participation i classes includ plan			Self-study SUM		SUM	
	Number of study hours	15		1.0		9.0		25
Subject objectives	The aim is introduction to : the essence of measurement, units and standards, methods of measurement, analysis of measurement uncertainty, basic instruments for measurement of electrical quantities.							
Learning outcomes	Course out	Subject outcome			Method of verification			
	[K6_W02] Knows and understands, to an advanced extent, selected laws of physics and physical phenomena as well as methods and theories explaining the complex relationships between them, constituting the basic general knowledge in the field of technical sciences related to the field of study		He knows the basic metrological terms. He knows the measurement methods. It strictly defines the measurand (menzurand). It presents the results of measurements according to the recommendations of the International System of Units (SI), using the correct markings and prefixes to create multiple and submultiple units of measurement. Student analyzes systematic errors in direct and indirect measurements. Student knows the causes of measurement uncertainty and methods of its minimization during measurement uncertainty with the A-method and B-methods.		[SW1] Assessment of factual knowledge			
	[K6_W03] Knows and understands, to an advanced extent, the construction and operating principles of components and systems related to the field of study, including theories, methods and complex relationships between them and selected specific issues - appropriate for the curriculum		Student knows the structure and metrological properties of instruments for measuring basic electrical quantities. He knows the principles of operation of analog / digital converters. Student knows the methods of constructing measurement systems.		[SW1] Assessment of factual knowledge			

1. Introduction, basic metrological terms, classification of measurement methods 2. Measurement errors, types of errors: systematic, random, gross 3. Permanent-magnet moving-coil instrument and its application 4. Digital methods of low and high frequency measurements 5. Digital methods of time-interval and phase measurements 6. Dual-slope integration ADC 7. Immunity of integration ADCs from disturbances 8. Flash and subranging ADC 9. Digital multimeters: architecture, resistance to voltage converter, current to voltage converter, multiterminal inputs 10. AC voltage measurements, waveform parameters, average value, peak value and RMS measurements 11. Oscilloscope: architecture, principles of operation 12. Measurement of voltage, frequency, phase, parameters of pulse, display of device characteristics 13. Measurement uncertainty 14. Measurement methods of impedance parameters R, L, C,  Z  15. Measuring systems and virtual instruments.

Prerequisites and co-requisites	Presentations from the lectures are of exempt them from the need to take the applicable textbooks. The lecture colloquium is valid for the scope of the corresponding fragments of the texts         Completion of the lecture in the subjection of the lecture.         Place: rooms EA222 / EA442         Groups of 16 people will be admitted laboratory computers.         Time to perform the test: 15 minutes         Number of questions: 20 (10 from S.         After the time has elapsed, an open of the combination will result in not as         Baseline results will be known as soor         Grades must be issued by the end of the class, but not sooner than 5 days         The maximum grade that can be obt         Percentage thresholds for individual         <0; 49>% 2         <50; 60)% 3.	heir own lecture notes and does not a is only a supplement to the student be material actually laid out during the pooks given in the list of literature for ect takes place in the multiple-choice I to the room and they will solve the t Babicz, 10 from St. Gall) sample will be saved automatically. d the questions are tested with zero-of t for the question, you need to mark ssigning a point for this question. on as the test is completed. f the class. Therefore, the retake dat a after the basic test is written. ained from the resit date is 3.	replace the independent study of s independent work. The e lecture and contained in the the lecture. e test after a minimum of two weeks est on the e-learning platform on one. So if the answers A and C are exactly the answers A and C. Any			
	<70; 80)% 4					
	<80; 90)% 4.5					
	<90; 100>% 5					
	It is not possible to increase the grade / performance of an additional task for a higher grade etc.					
Assessment methods and criteria	Subject passing criteria Colloquium	Passing threshold 50.0%	Percentage of the final grade 100.0%			

Recommended reading	Basic literature	<ul> <li>Piotrowski J., Podstawy Metrologii, PWN 1977</li> <li>Piotrowski J., Podstawy miernictwa, WNT 2000</li> <li>Parchański J., Miernictwo elektryczne i elektroniczne, WSP 1998</li> <li>Jaworski J., Morawski R., Olędzki J., Wstęp do metrologii i techniki eksperymentu, WNT 1992</li> <li>Piotrowski J., Podstawy metrologii, Politechnika Śląska 1971</li> <li>Taylor J. R., Wstęp do analizy błędu pomiarowego, PWN 1999</li> <li>Tumański S., Technika pomiarowa, WNT 2007</li> <li>Chwaleba A., Poniński M., Siedlecki A., Metrologia elektryczna, WNT 2009</li> </ul>			
	Supplementary literature	<ul> <li>Domańska A., Barzykowski J., Kujawińska M., Współczesna metrologia wybrane zagadnienia, WNT 2016</li> <li>Jakubiec W., Malinowski J., Metrologia wielkości geometrycznych, PWN 2018</li> <li>Bewoor A. K., Kulkarni V. A., Metrology &amp; Measurements, Tata McGraw-Hill Education 2009 (dostępna częściowo w books.gogle)</li> <li>Banerjee G. K., Electrical And Electronic Measurements, PHI Learning Pvt. Ltd (books.gogle)</li> </ul>			
	eResources addresses	Adresy na platformie eNauczanie:			
		Metrologia - Wykład EiT/ACiR/IBM 2024 - Moodle ID: 34712 https://enauczanie.pg.edu.pl/moodle/course/view.php?id=34712			
Example issues/ example questions/ tasks being completed	https://enauczanie.pg.edu.pl/moodle/course/view.php?id=34712 1 Two voltmeters could be used to measure the voltage U = 12 V. The first was a class 0.5 laboratory voltmeter with a measuring range of 60 V, and the second was a class 1.5 blackboard voltmeter with a measuring range of 15 V. Which voltmeter allowed the voltage value to be determined with less error?2) What is the measured frequency if 3587 pulses were counted in the 10 ms gate-opening time of the frequency meter.3. a frequency meter, normally operating with an internal reference frequency source of 1 MHz, was used with an external reference generator of 4 MHz. How should the frequency measurement results be corrected: (a) multiply by 4, (b) multiply by 2, (c) divide by 4.4. represent in the figure the voltage waveform that occurs at the output of the integrator in an A/D converter with double integration processing. Mark with "a" the time interval in which the reference voltage is integrated, with "b" the time interval in which the measured voltage is integrated, with "c" the time interval proportional to the measured voltage, with "d" the moment when the state of the comparator output changes, with "e" the moment when the counter overflows, with "f" the time interval which is to be equal to 20 ms to ensure immunity of the converter to mains frequency interference. The Y channel of the oscilloscope has a bandwidth of 40 MHz. What is the rise time of the step response of the oscilloscope. What is the rise time of the pulse you will read from the screen of this oscilloscope if you are testing a pulse whose rise time is 20 ns.6. The uncertainty of the voltage measurement is expressed in the multimeter specification as $\pm(1\%+2 \text{ digits})$ and the reading is 1.200 V. Calculate the uncertainty of the voltage measurement.7 Explain the meaning of the abbreviations read from the face plate of the multimeter: AC, DC, 2W, 4W.8. Express the voltage ratios in dB: U1/U2 = 103, 1, 10-2.9. give the rms and peak-to-peak value of the voltage in a				
Work placement	Not applicable				